



2621 #4
1-30-03

Docket No.: GR 98 P 8116 P

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By: [Signature]

Date: January 17, 2003

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Ivo Koren et al.
Applic. No. : 09/822,021
Filed : March 30, 2001
Title : Method And Device For Correcting Defective Pixels Of An Image Sensor
Art Unit : 2621

INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner of Patents and Trademarks,
Washington, D.C. 20231

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Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

United States Patent No. 5,381,175 (Sudo et al.), dated January 10, 1995;

European Patent Application EP 0 440 563 A2 (Sudo et al.), dated August 7, 1991;

Japanese Patent Abstract JP 09 168 120 (Shimura), dated June 24, 1997.

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications,

patents and/or publications, it is because no existing translation is readily available to the applicant.

Respectfully submitted,



For Applicants

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Date: January 17, 2003

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FORM PTO-1449 (SUBSTITUTE)

Attorney Docket No.:

Applic. No.

GR 98 P 8116 P

09/822,021

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEINFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(37 CFR 1.98(b))

Applicant

Ivo Koren et al.

Filing Date

March 30, 2001

Group Art Unit

2621

U.S. PATENT DOCUMENTS

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A	5,381,175	01/10/95	Sudo et al.			
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						

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FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	0 440 563 A2	08/07/91	Europe			X
	K	09 168 120	06/24/97	Japan			X
	L						
	M						
	N						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	O	
	P	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609;
Draw line through citation if not in conformance and not considered. Include copy of this form with
next communication to applicant.